

XA-9640 PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Toshihiro TANAKA et al.

Appln. No.: 10/083,399

Group Art Unit: 2133

Filed: February 27, 2002

Examiner: P. Chung

For: SEMICONDUCTOR INTEGRATED CIRCUIT AND A METHOD OF

TESTING THE SAME

AMENDMENT ACCOMPANYING REQUEST FOR CONTINUED EXAMINATION

Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Sir:

Prior to the commencement of continued examination, please amend the above-identified patent application as indicated below.

Amendments to the claims are reflected in the listing of claims, which begins on page 2 of this paper.

Remarks/Arguments begin on page 15 of this paper.